

# Silizium-PIN-Fotodiode mit Tageslichtsperrfilter

## Silicon-PIN-Photodiode with Daylight Filter

### SFH 205 F



#### Wesentliche Merkmale

- Speziell geeignet für Anwendungen bei 950 nm
- Kurze Schaltzeit (typ. 20 ns)
- 5 mm-Plastikbauform im LED-Gehäuse
- Auch gegurtet lieferbar

#### Anwendungen

- IR-Fernsteuerung von Fernseh- und Rundfunkgeräten, Videorecordern, Lichtdimmern, Gerätefernsteuerungen
- Lichtschranken für Gleich- und Wechsellichtbetrieb

| Typ<br>Type | Bestellnummer<br>Ordering Code |
|-------------|--------------------------------|
| SFH 205 F   | Q62702-P102                    |

#### Features

- Especially suitable for applications of 950 nm
- Short switching time (typ. 20 ns)
- 5 mm LED plastic package
- Also available on tape and reel

#### Applications

- IR-remote control of hi-fi and TV sets, video tape recorders, dimmers, remote control of various equipment
- Photointerrupters

**Grenzwerte**  
**Maximum Ratings**

| Bezeichnung<br>Parameter  | Symbol<br>Symbol  | Wert<br>Value  | Einheit<br>Unit |
|---|-------------------|----------------|-----------------|
| Betriebs- und Lagertemperatur<br>Operating and storage temperature range  | $T_{op}; T_{stg}$ | - 40 ... + 100 | °C              |
| Löttemperatur (Lötstelle 2 mm vom Gehäuse entfernt bei Lötzeit $t \leq 3$ s)<br>Soldering temperature in 2 mm distance from case bottom ( $t \leq 3$ s) | $T_s$             | 230            | °C              |
| Sperrspannung<br>Reverse voltage  | $V_R$             | 32             | V               |
| Verlustleistung, $T_A = 25$ °C<br>Total power dissipation   | $P_{tot}$         | 150            | mW              |

**Kennwerte ( $T_A = 25$  °C,  $\lambda = 950$  nm)**
**Characteristics**

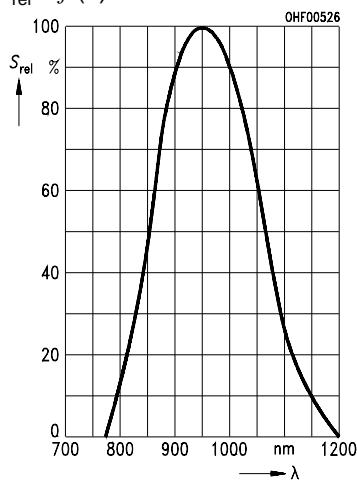
| Bezeichnung<br>Parameter   | Symbol<br>Symbol             | Wert<br>Value    | Einheit<br>Unit |
|--|------------------------------|------------------|-----------------|
| Fotostrom<br>Photocurrent<br>$V_R = 5$ V, $E_e = 1$ mW/cm <sup>2</sup>   | $I_P$                        | 60 ( $\geq 45$ ) | µA              |
| Wellenlänge der max. Fotoempfindlichkeit<br>Wavelength of max. sensitivity   | $\lambda_{S\ max}$           | 950              | nm              |
| Spektraler Bereich der Fotoempfindlichkeit<br>$S = 10\%$ von $S_{max}$<br>Spectral range of sensitivity<br>$S = 10\%$ of $S_{max}$ | $\lambda$                    | 800 ... 1100     | nm              |
| Bestrahlungsempfindliche Fläche<br>Radiant sensitive area  | A                            | 7.00             | mm <sup>2</sup> |
| Abmessungen der bestrahlungsempfindlichen Fläche<br>Dimensions of radiant sensitive area   | $L \times B$<br>$L \times W$ | 2.65 × 2.65      | mm × mm         |
| Abstand Chipoberfläche zu Gehäuseoberfläche<br>Distance chip surface to case surface   | H                            | 2.3 ... 2.5      | mm              |
| Halbwinkel<br>Half angle   | φ                            | ± 60             | Grad<br>deg.    |
| Dunkelstrom, $V_R = 10$ V<br>Dark current  | $I_R$                        | 2 ( $\leq 30$ )  | nA              |

Kennwerte ( $T_A = 25^\circ\text{C}$ ,  $\lambda = 950 \text{ nm}$ )

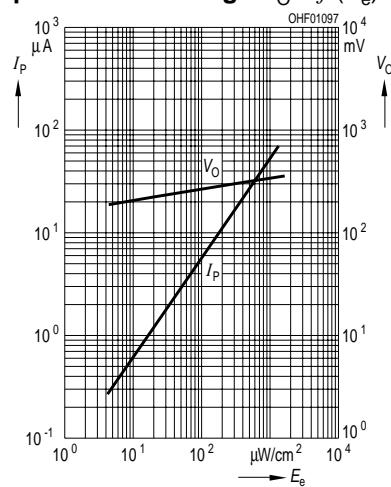
Characteristics (cont'd)

| Bezeichnung<br>Parameter   | Symbol<br>Symbol | Wert<br>Value         | Einheit<br>Unit                                      |
|--|------------------|-----------------------|--|
| Spektrale Fotoempfindlichkeit<br>Spectral sensitivity  | $S_\lambda$      | 0.59                  | $\text{A}/\text{W}$                                  |
| Quantenausbeute<br>Quantum yield   | $\eta$           | 0.77                  | Electrons<br>Photon                                  |
| Leerlaufspannung, $E_e = 0.5 \text{ mW/cm}^2$<br>Open-circuit voltage  | $V_O$            | 330 ( $\geq 250$ )    | $\text{mV}$  |
| Kurzschlußstrom, $E_e = 0.5 \text{ mW/cm}^2$<br>Short-circuit current  | $I_{SC}$         | 28                    | $\mu\text{A}$  |
| Anstiegs- und Abfallzeit des Fotostromes<br>Rise and fall time of the photocurrent<br>$R_L = 50 \Omega$ ; $V_R = 5 \text{ V}$ ; $\lambda = 850 \text{ nm}$ ; $I_p = 800 \mu\text{A}$ | $t_r, t_f$       | 20                    | ns   |
| Durchlaßspannung, $I_F = 100 \text{ mA}$ , $E = 0$<br>Forward voltage  | $V_F$            | 1.3                   | V  |
| Kapazität, $V_R = 0 \text{ V}$ , $f = 1 \text{ MHz}$ , $E = 0$<br>Capacitance  | $C_0$            | 72                    | pF   |
| Temperaturkoeffizient von $V_O$<br>Temperature coefficient of $V_O$  | $TC_V$           | - 2.6                 | $\text{mV/K}$  |
| Temperaturkoeffizient von $I_{SC}$<br>Temperature coefficient of $I_{SC}$  | $TC_I$           | 0.18                  | %/K  |
| Rauschäquivalente Strahlungsleistung<br>Noise equivalent power<br>$V_R = 10 \text{ V}$   | NEP              | $4.3 \times 10^{-14}$ | $\frac{\text{W}}{\sqrt{\text{Hz}}}$                  |
| Nachweisgrenze, $V_R = 10 \text{ V}$<br>Detection limit  | $D^*$            | $6.2 \times 10^{12}$  | $\frac{\text{cm} \times \sqrt{\text{Hz}}}{\text{W}}$ |

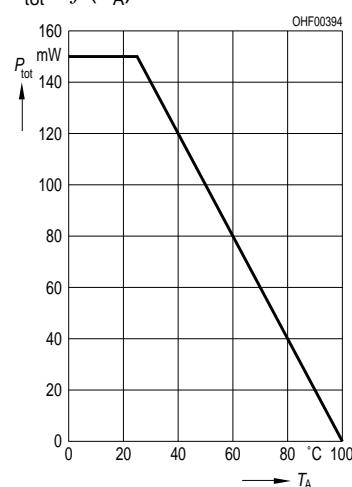
**Relative Spectral Sensitivity**  
 $S_{\text{rel}} = f(\lambda)$



**Photocurrent  $I_P = f(E_e)$ ,  $V_R = 5 \text{ V}$**   
**Open-Circuit Voltage  $V_O = f(E_e)$**

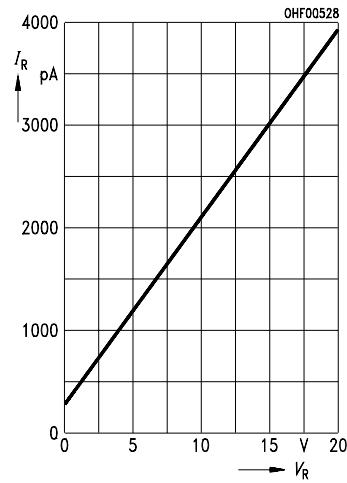


**Total Power Dissipation**  
 $P_{\text{tot}} = f(T_A)$



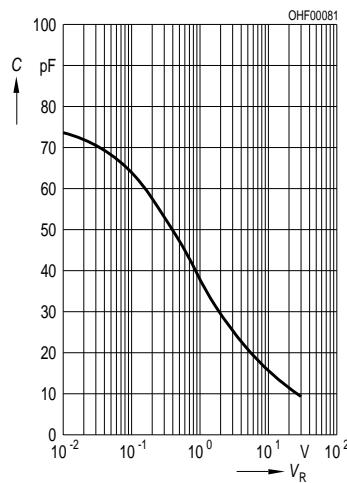
**Dark Current**

$$I_R = f(V_R), E = 0$$



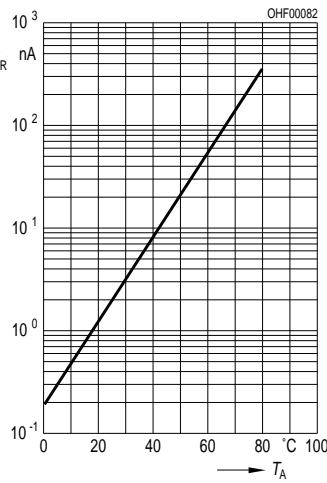
**Capacitance**

$$C = f(V_R), f = 1 \text{ MHz}, E = 0$$



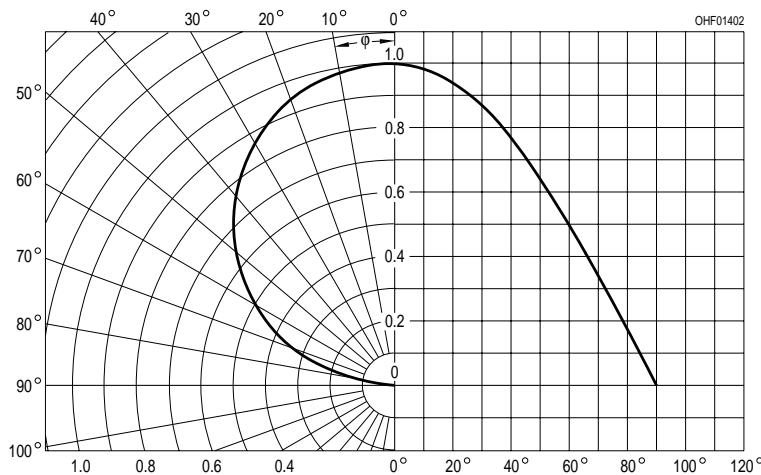
**Dark Current**

$$I_R = f(T_A), V_R = 10 \text{ V}, E = 0$$

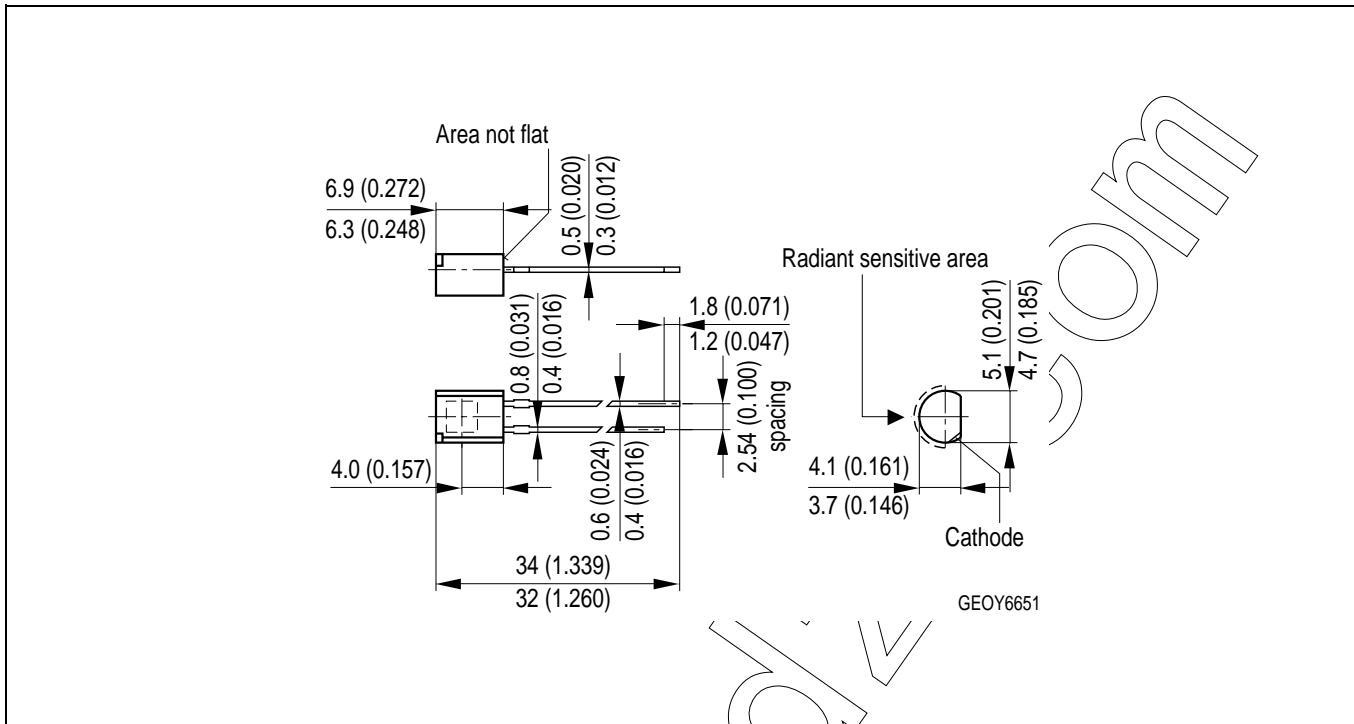


**Directional Characteristics**

$$S_{\text{rel}} = f(\phi)$$



# Maßzeichnung Package Outlines



Maße werden wie folgt angegeben: mm (inch) / Dimensions are specified as follows: mm (inch).

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Terms of delivery and rights to change design reserved. Due to technical requirements components may contain dangerous substances. For information on the types in question please contact our Sales Organization.

## Packing

Please use the recycling operators known to you. We can also help you – get in touch with your nearest sales office. By agreement we will take packing material back, if it is sorted. You must bear the costs of transport. For packing material that is returned to us unsorted or which we are not obliged to accept, we shall have to invoice you for any costs incurred.

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<sup>2</sup> Life support devices or systems are intended (a) to be implanted in the human body, or (b) to support and/or maintain and sustain human life. If they fail, it is reasonable to assume that the health of the user may be endangered.

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